

# IRFI4510GPbF

HEXFET® Power MOSFET

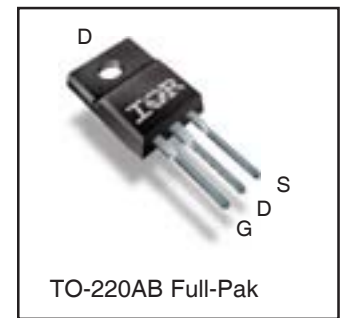
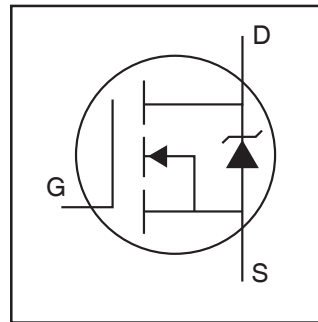
## Applications

- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

## Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free
- Halogen-Free

|                          |               |
|--------------------------|---------------|
| $V_{DSS}$                | <b>100V</b>   |
| $R_{DS(on)}$ <b>typ.</b> | <b>10.7mΩ</b> |
|                          | <b>13.5mΩ</b> |
| $I_D$                    | <b>35A</b>    |



|          |          |          |
|----------|----------|----------|
| <b>G</b> | <b>D</b> | <b>S</b> |
| Gate     | Drain    | Source   |

## Absolute Maximum Ratings

| Symbol                          | Parameter  | Max.             | Units |
|---------------------------------|--|------------------|-------|
| $I_D @ T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10\text{V}$            | 35               | A     |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$            | 24               |       |
| $I_{DM}$                        | Pulsed Drain Current ①                                     | 180              |       |
| $P_D @ T_C = 25^\circ\text{C}$  | Maximum Power Dissipation                                  | 42               | W     |
|                                 | Linear Derating Factor                                     | 0.28             | W/°C  |
| $V_{GS}$                        | Gate-to-Source Voltage                                     | ±20              | V     |
| $E_{AS}$ (Thermally limited)    | Single Pulse Avalanche Energy ②                            | 206              | mJ    |
| $T_J$<br>$T_{STG}$              | Operating Junction and<br>Storage Temperature Range        | -55 to + 175     | °C    |
|                                 | Soldering Temperature, for 10 seconds<br>(1.6mm from case) | 300              |       |
|                                 | Mounting torque, 6-32 or M3 screw                          | 10lb·in (1.1N·m) |       |

## Thermal Resistance

|                 | Parameter             | Typ. | Max. | Units |
|-----------------|-----------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case ④    | ---  | 3.6  | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient ④ | ---  | 65   |       |

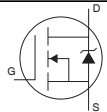
Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

| Symbol                          | Parameter                            | Min. | Typ. | Max. | Units              | Conditions  |
|---------------------------------|--------------------------------------|------|------|------|--------------------|---|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 100  | —    | —    | V                  | $V_{GS} = 0V, I_D = 250\mu A$                         |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.11 | —    | $V/^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D = 5\text{mA}$ ③   |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 10.7 | 13.5 | $\text{m}\Omega$   | $V_{GS} = 10V, I_D = 21A$ ③                           |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —    | 4.0  | V                  | $V_{DS} = V_{GS}, I_D = 100\mu A$                     |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 20   | $\mu A$            | $V_{DS} = 100V, V_{GS} = 0V$                          |
|                                 |                                      | —    | —    | 250  |                    | $V_{DS} = 100V, V_{GS} = 0V, T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA                 | $V_{GS} = 20V$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |                    | $V_{GS} = -20V$                                       |
| $R_{G(int)}$                    | Internal Gate Resistance             | —    | 0.6  | —    | $\Omega$           |   |

Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

| Symbol                      | Parameter                                     | Min. | Typ. | Max. | Units  | Conditions   |
|-----------------------------|---|------|------|------|--|--|
| $g_{fs}$                    | Forward Transconductance                      | 55   | —    | —    | S  | $V_{DS} = 50V, I_D = 21A$                                |
| $Q_g$                       | Total Gate Charge                             | —    | 54   | 81   | nC   | $I_D = 21A$  |
| $Q_{gs}$                    | Gate-to-Source Charge                         | —    | 13   | —    |  | $V_{DS} = 50V$   |
| $Q_{gd}$                    | Gate-to-Drain ("Miller") Charge               | —    | 16   | —    |  | $V_{GS} = 10V$ ③   |
| $t_{d(on)}$                 | Turn-On Delay Time                            | —    | 16   | —    | ns   | $V_{DD} = 65V$   |
| $t_r$                       | Rise Time                                     | —    | 33   | —    |  | $I_D = 21A$  |
| $t_{d(off)}$                | Turn-Off Delay Time                           | —    | 54   | —    |  | $R_G = 7.5\Omega$  |
| $t_f$                       | Fall Time                                     | —    | 37   | —    |  | $V_{GS} = 10V$ ③   |
| $C_{iss}$                   | Input Capacitance                             | —    | 2998 | —    | pF   | $V_{GS} = 0V$  |
| $C_{oss}$                   | Output Capacitance                            | —    | 216  | —    |  | $V_{DS} = 50V$   |
| $C_{rss}$                   | Reverse Transfer Capacitance                  | —    | 103  | —    |  | $f = 1.0\text{MHz}$                                      |
| $C_{oss \text{ eff. (ER)}}$ | Effective Output Capacitance (Energy Related) | —    | 261  | —    |  | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$ ⑥, See Fig.11 |
| $C_{oss \text{ eff. (TR)}}$ | Effective Output Capacitance (Time Related)   | —    | 494  | —    | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V$ ⑤ |  |

## Diode Characteristics

| Symbol    | Parameter                                 | Min.   | Typ. | Max. | Units | Conditions   |
|-----------|---|--|------|------|-------|--|
| $I_S$     | Continuous Source Current<br>(Body Diode) | —  | —    | 35   | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$  | Pulsed Source Current<br>(Body Diode) ①   | —  | —    | 180  | A     |  |
| $V_{SD}$  | Diode Forward Voltage                     | —  | —    | 1.3  | V     | $T_J = 25^\circ\text{C}, I_S = 21A, V_{GS} = 0V$ ③   |
| $t_{rr}$  | Reverse Recovery Time                     | —  | 39   | 59   | ns    | $T_J = 25^\circ\text{C}$   |
|           |   | —  | 47   | 71   |       | $T_J = 125^\circ\text{C}$  |
| $Q_{rr}$  | Reverse Recovery Charge                   | —  | 63   | 95   | nC    | $T_J = 25^\circ\text{C}$   |
|           |   | —  | 90   | 135  |       | $T_J = 125^\circ\text{C}$  |
| $I_{RRM}$ | Reverse Recovery Current                  | —  | 2.9  | —    | A     | $T_J = 25^\circ\text{C}$   |
| $t_{on}$  | Forward Turn-On Time                      | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) |      |      |       |  |

## Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.93\text{mH}$   
 $R_G = 50\Omega, I_{AS} = 21A, V_{GS} = 10V$ . Part not recommended for use above this value.
- ③ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .

- ⑤  $C_{oss \text{ eff. (TR)}}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to  $80\% V_{DSS}$ .
- ⑥  $C_{oss \text{ eff. (ER)}}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to  $80\% V_{DSS}$ .

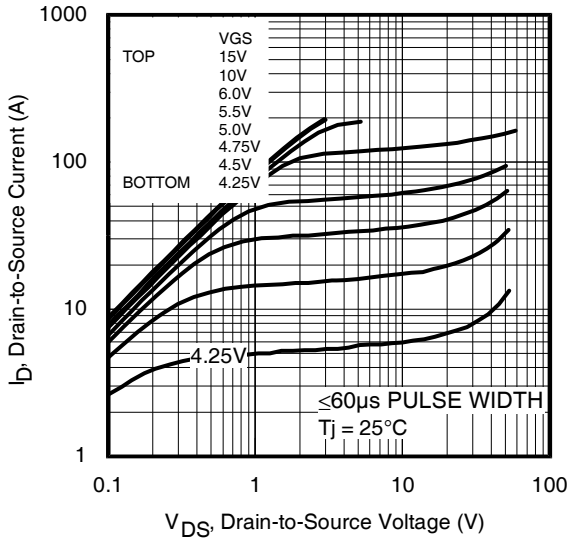


Fig 1. Typical Output Characteristics

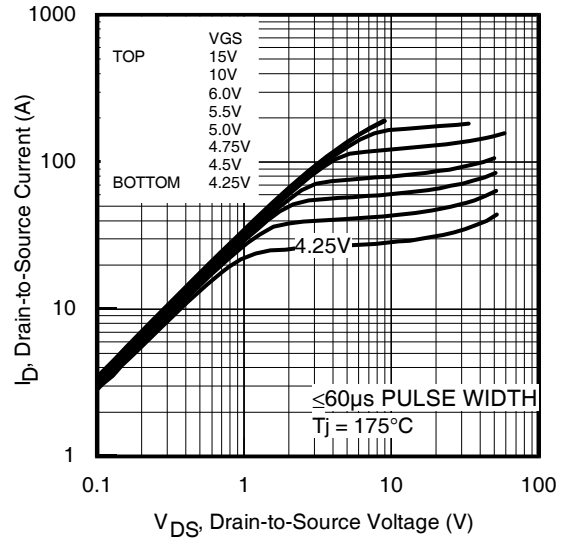


Fig 2. Typical Output Characteristics

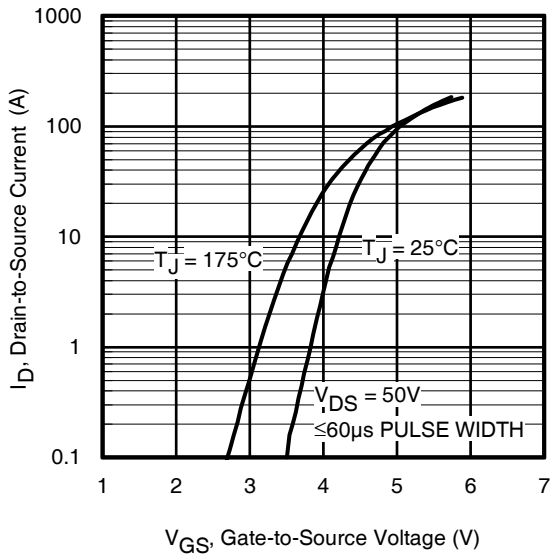


Fig 3. Typical Transfer Characteristics

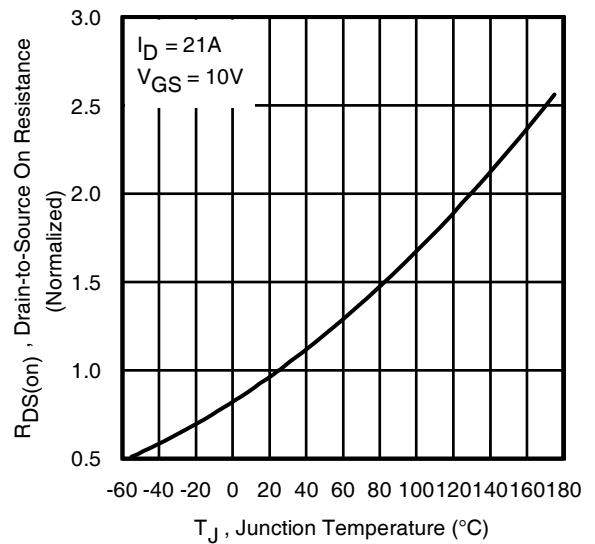


Fig 4. Normalized On-Resistance vs. Temperature

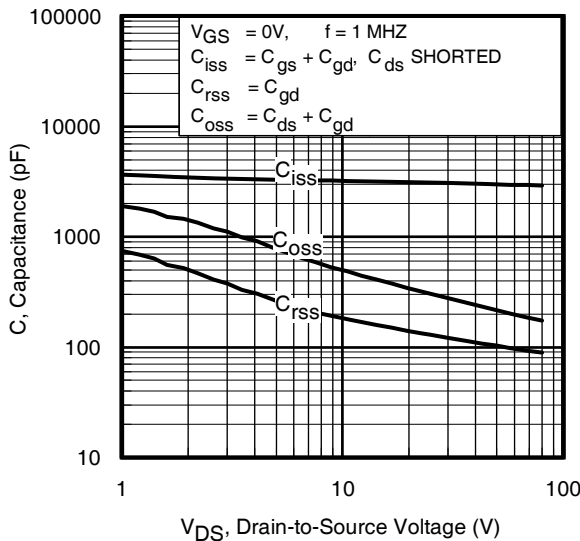


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

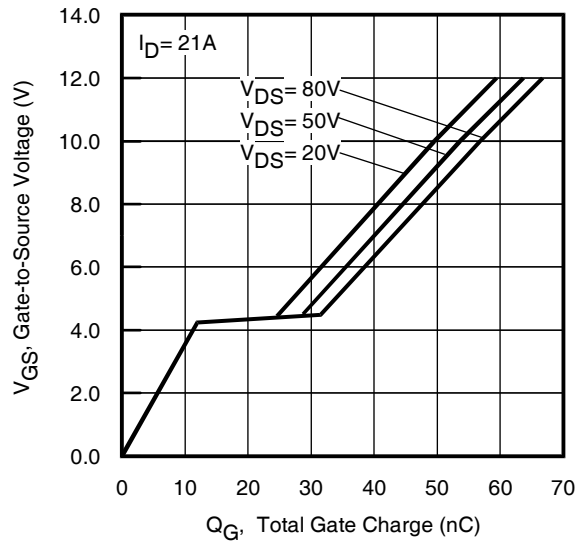
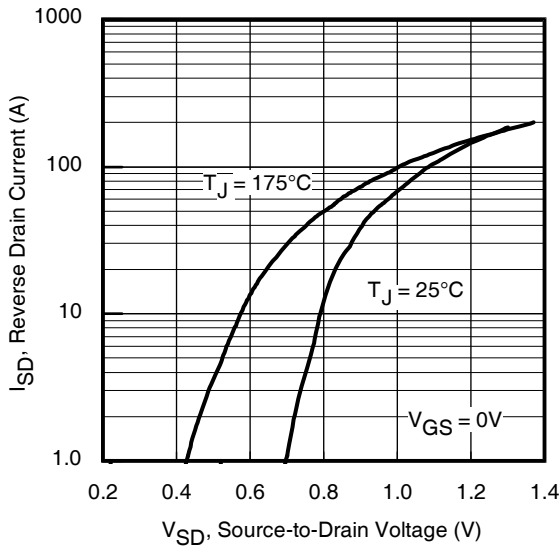
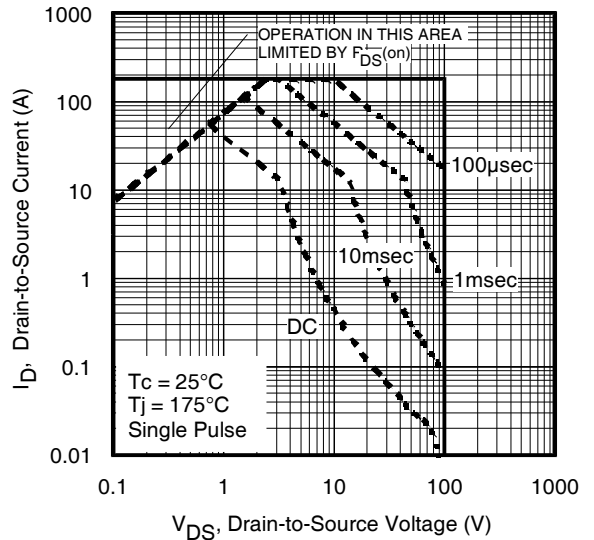


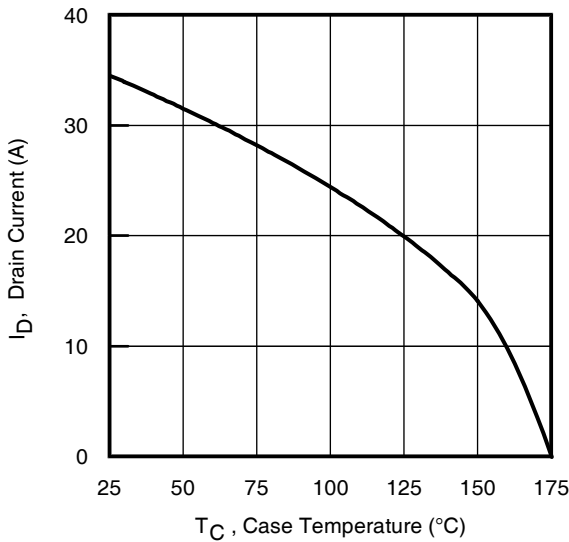
Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



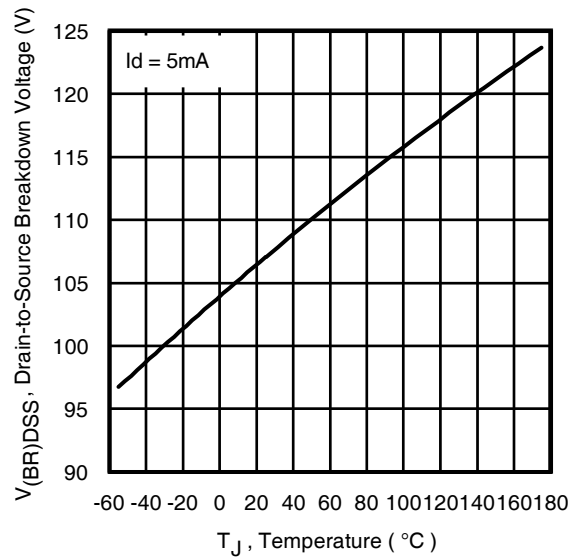
**Fig 7.** Typical Source-Drain Diode Forward Voltage



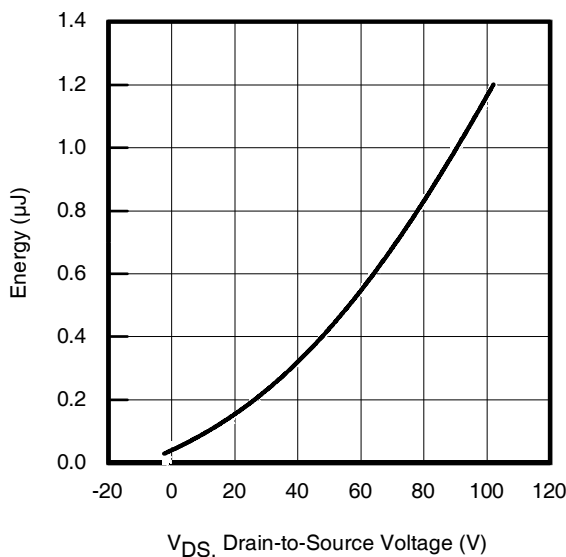
**Fig 8.** Maximum Safe Operating Area



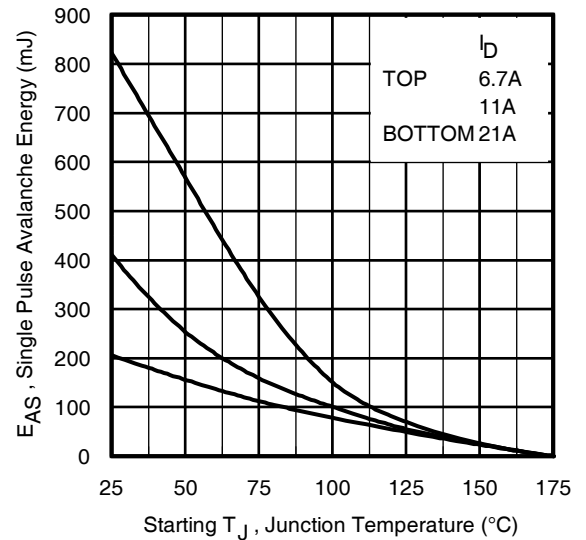
**Fig 9.** Maximum Drain Current vs. Case Temperature



**Fig 10.** Drain-to-Source Breakdown Voltage



**Fig 11.** Typical  $C_{OSS}$  Stored Energy



**Fig 12.** Maximum Avalanche Energy vs. Drain Current

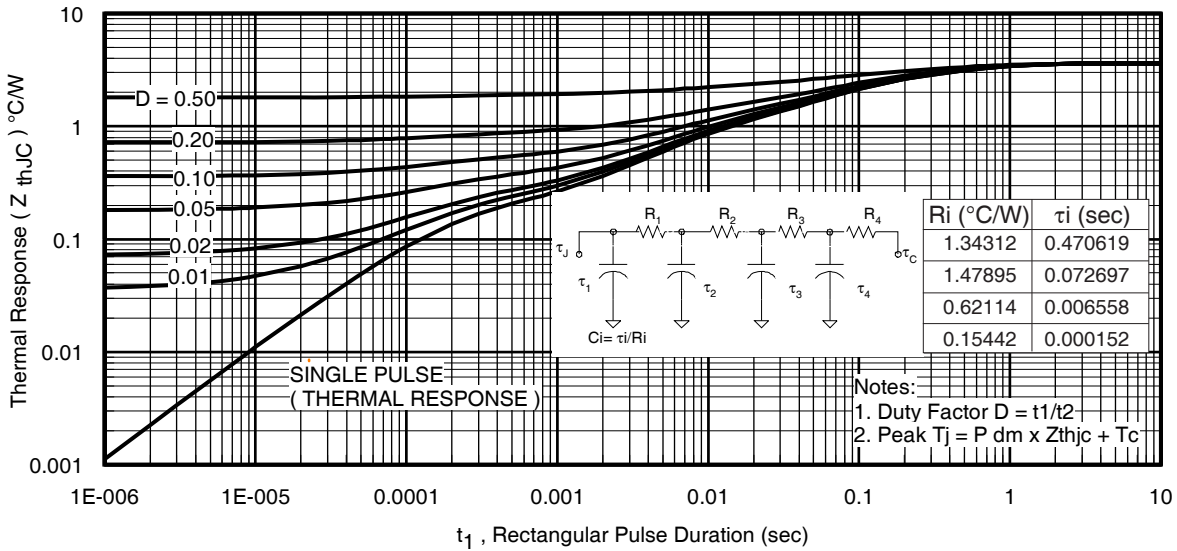


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

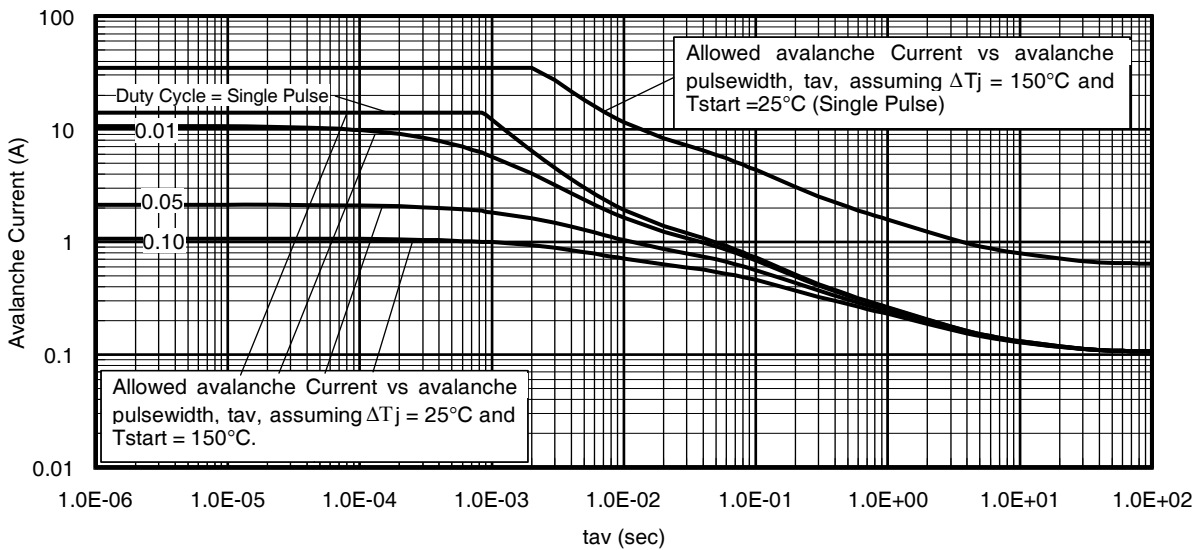


Fig 14. Typical Avalanche Current vs. Pulsewidth

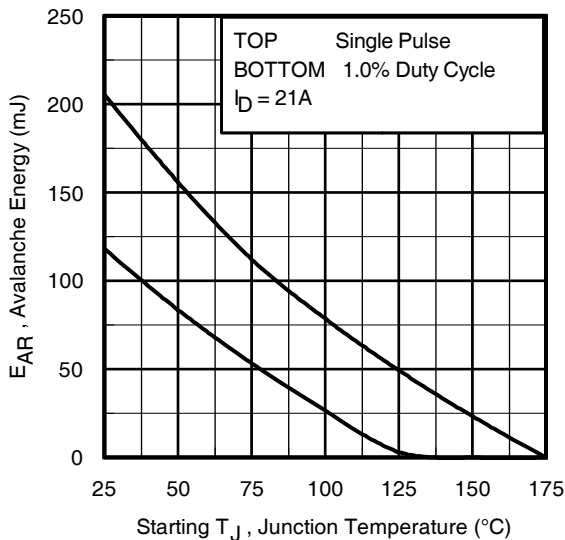


Fig 15. Maximum Avalanche Energy vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 14, 15:**  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

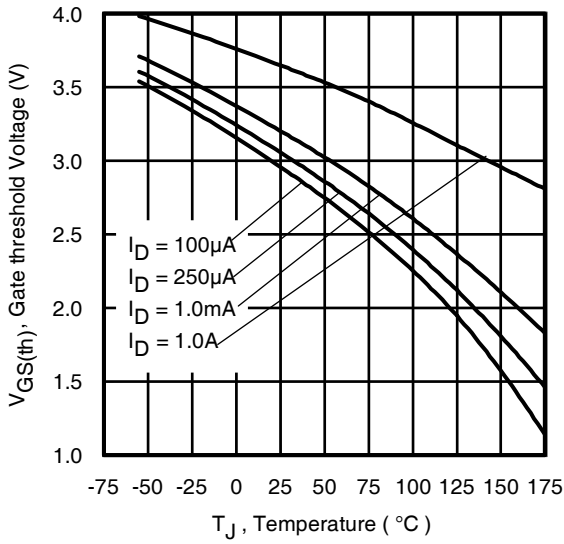


Fig 16. Threshold Voltage vs. Temperature

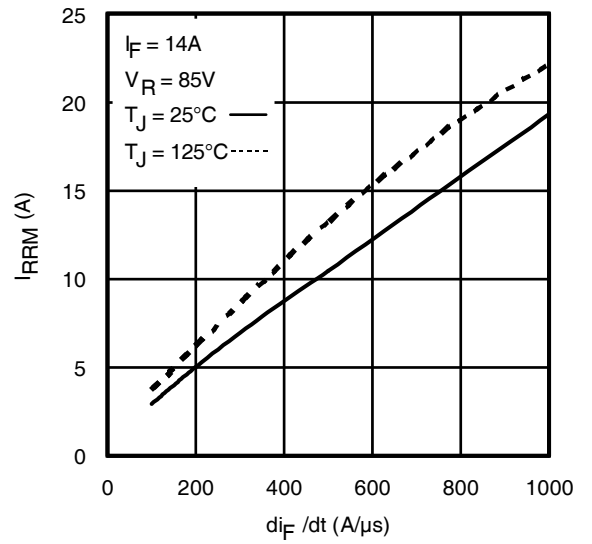


Fig. 17 - Typical Recovery Current vs.  $di_F/dt$

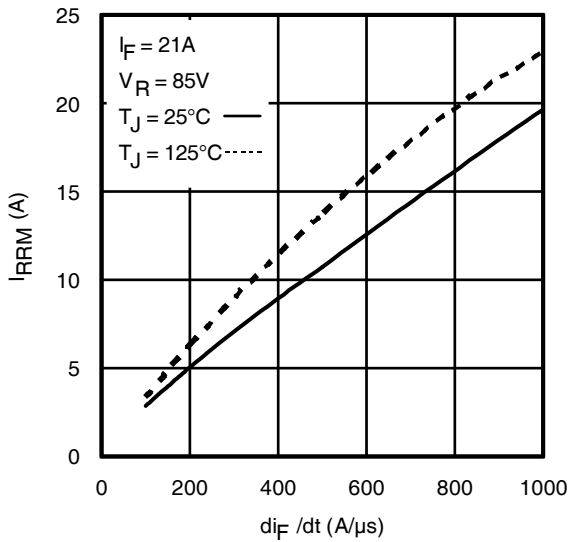


Fig. 18 - Typical Recovery Current vs.  $di_F/dt$

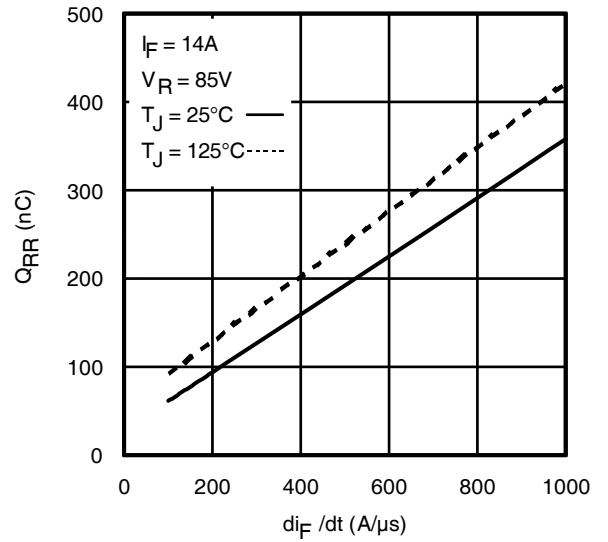


Fig. 19 - Typical Stored Charge vs.  $di_F/dt$

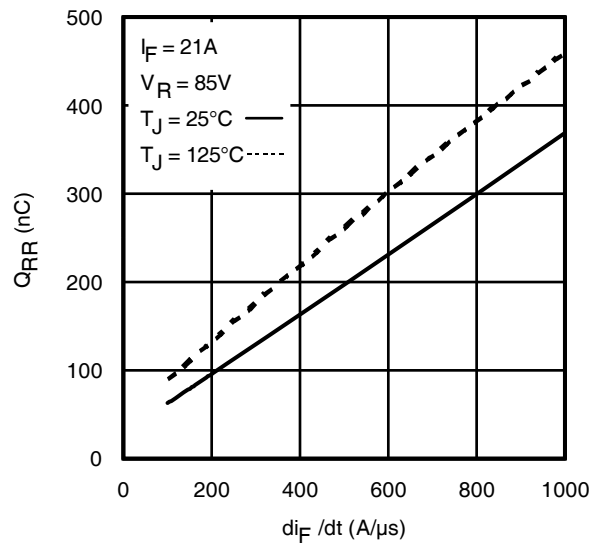


Fig. 20 - Typical Stored Charge vs.  $di_F/dt$



\*  $V_{GS} = 5V$  for Logic Level Devices

**Fig 21. Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET<sup>®</sup> Power MOSFETs**



**Fig 22a. Unclamped Inductive Test Circuit**



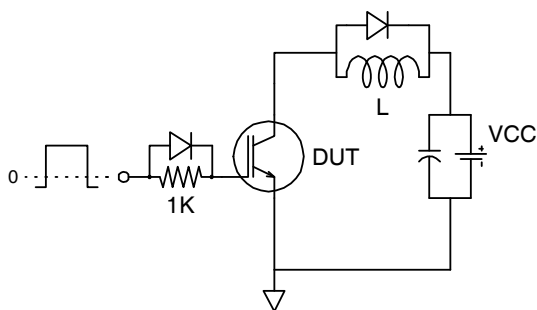
**Fig 22b. Unclamped Inductive Waveforms**



**Fig 23a. Switching Time Test Circuit**



**Fig 23b. Switching Time Waveforms**

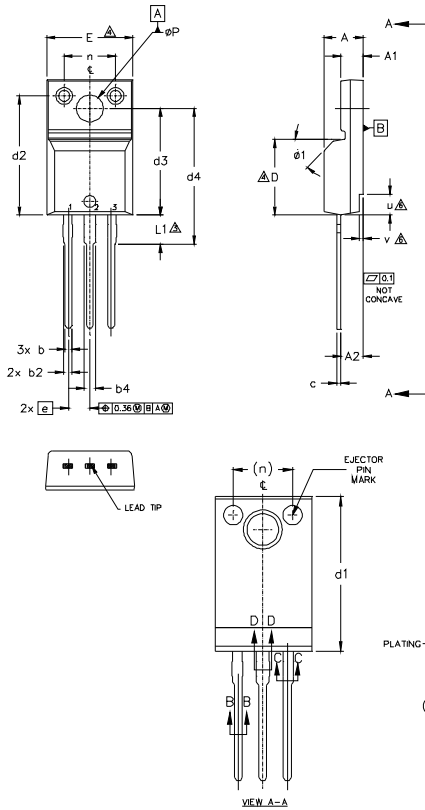


**Fig 24a. Gate Charge Test Circuit**



**Fig 24b. Gate Charge Waveform**

TO-220AB Full-Pak Package Outline (Dimensions are shown in millimeters (inches))



- NOTES:
- 1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
  - 2.0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
  - 3.0 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
  - 4.0 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.
  - 5.0 DIMENSION b1, b3, b5 & c1 APPLY TO BASE METAL ONLY.
  - 6.0 STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.
  - 7.0 CONTROLLING DIMENSION : INCHES.

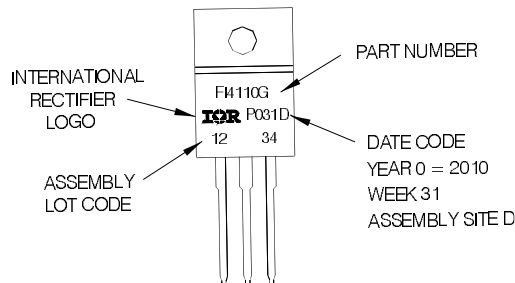
| SYMBOL | DIMENSIONS  |       |          |      | NOTES |   |
|--------|-------------|-------|----------|------|-------|---|
|        | MILLIMETERS |       | INCHES   |      |       |   |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |   |
| A      | 4.57        | 4.83  | .180     | .190 | 5     |   |
| A1     | 2.57        | 2.83  | .101     | .111 |       |   |
| A2     | 2.41        | 2.92  | .095     | .115 |       |   |
| b      | 0.62        | .094  | 0.24     | .037 |       |   |
| b1     | 0.62        | 0.89  | .024     | 0.35 |       |   |
| b2     | 0.76        | 1.27  | .030     | .050 |       |   |
| b3     | 0.76        | 1.22  | .030     | .048 |       |   |
| b4     | 1.02        | 1.52  | .040     | .060 |       |   |
| b5     | 1.02        | 1.47  | .040     | .058 |       |   |
| c      | 0.33        | 0.63  | .013     | .025 |       |   |
| c1     | 0.33        | 0.58  | .013     | .023 |       |   |
| D      | 8.65        | 9.80  | .341     | .386 |       | 4 |
| d1     | 15.80       | 16.12 | .622     | .635 |       | 4 |
| d2     | 13.97       | 14.22 | .550     | .560 |       |   |
| d3     | 12.30       | 12.92 | .484     | .509 |       |   |
| d4     | 8.64        | 9.91  | .340     | .390 |       |   |
| E      | 9.63        | 10.63 | .379     | .419 |       |   |
| e      | 2.54 BSC    |       | .100 BSC |      | 3     |   |
| L      | 13.20       | 13.72 | .520     | .540 |       |   |
| L1     | 3.10        | 2.31  | .122     | .138 |       |   |
| n      | 6.05        | 6.15  | .238     | .242 | 6     |   |
| phi P  | 3.05        | 3.45  | .120     | .136 |       |   |
| u      | 2.40        | 2.50  | .094     | .098 | 6     |   |
| v      | 0.40        | 0.50  | .016     | .020 |       |   |
| phi 1  | -           | 45°   | -        | 45°  |       |   |

- LEAD ASSIGNMENTS
- HEXFLET
- 1.- GATE
  - 2.- DRAIN
  - 3.- SOURCE
- IGBTs, CoPACK
- 1.- GATE
  - 2.- COLLECTOR
  - 3.- EMITTER

TO-220AB Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI4110G  
WITH ASSEMBLY  
LOT CODE 1234  
ASSEMBLED ON VVW 31, 2010

Notes: - "P" in assembly line position indicates "Lead-Free"  
- "G" suffix in part number indicates "Halogen-Free"



TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at: <http://www.irf.com/package/>

Data and specifications subject to change without notice.  
This product has been designed and qualified for the Industrial market.  
Qualification Standards can be found on IR's Web site.



单击下面可查看定价，库存，交付和生命周期等信息

[>>Infineon Technologies\(英飞凌\)](#)